		icals	India Pvt. Ltd.	ULR No. : TC890622000000089F
DOC No. : I Telephone : - FAX : 4 E-Mail : I	MCIND/22-23/LB/ 289.V1 +91 9871742221 1204299 <u>ouneet.kumar@mitsu</u> <u>hemicals.com</u> NA 286 (2010)	Sar 382	5 and 6, Swastik Industr and, Ahmedabad, Ahmad 2220	
REPORT NO : SC22SPI01032	2_2			DATE : 19 Dec, 2022
PART A. PARTICULARS OF SAME	PLE SUBMITTED			
a) Customer Name & Address		:	UNIQUE SUN POWER LL BL NO. 2281/2/1/1, SUB TADKESHWAR, NEAR AR MANDVI, SURAT, NA, GL	PLOT. 1-A, RETH MINNOR CANAL,
b) Nature of sample		:	-	
c) Grade/Variety/Type/Class Si	ze etc	:	NA	
d) Declare values, if any		:	-	
e) Batch No. & Date of Manufa	cture	:	/	
f) Quantity		:	26	
g) Date of Receipt		:	19 Dec, 2022	
h) BIS Seal		:	Verified by Sample Cell	
i) IO's Signature		:	Verified by Sample Cell	
j) Any other Information / Exp	iry Date, If any	:	/	
k) Date of Commencement of	Testing	:	19 Dec, 2022	
I) Date of Completion of Testin	ng	:	19 Dec, 2022	
m) Section Code		:	22ED759N	
n) Section Report No.		:	22ED759N_1_A1	
o) Report Type		:	Revised	
p) Reference Report No.		:	SC22SPI01032_1	
q) Remarks		:	Please refer attached te	est report

**Gita Kumari OIC SAMPLE CELL** (Authorized Signatory) Authorized on: 19 Dec, 2022 17:56 PM

1. Mitsui Chemicals India Pvt. Ltd.

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## Section Report No. : 22ED759N\_1\_A1

### PART B. SUPPLEMENTARY INFORMATION

1.	Reference to sampling procedure, wherever applicable.	Not Applicable
2.	Supporting documents for the measurements taken and results derived like graphs, table sketches and or photographs as appropriate to test report, if any.	Yes
3.	Deviation from the test methods as prescribed in relevant ISS/Work instruction, if any.	Not Applicable
3.	NABL Report required ?	Yes

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Hebin Manuel OIC Electrical (Authorized Signatory) Authorized on: 19 Dec, 2022 17:55 PM

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# Section Report No. : 22ED759N\_1\_A1

### IS 14286 (2010)

report.

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### PART C. TEST RESULT

S.No.	Clause No Table No. Sl. No	Parameter - Method of test	Test Description	Min Limit	Max Limit	Unit	Result/ Observation
1	10.18	Bypass diode thermal' test	-	-	-	-	114.86 °C (The diod junction temperature did not exceed the diode manufacturer' maximum junction temperature limit. and the samples me the following requirements, 1. Visual Inspection tes found 2. Maximum power determination Power degradation≤ 5% 3. Insulation test - The measured insulation resistance was not less than 15.50 MΩ. For more details, please refer test report.
2	10.17	Hail test	-	-	-	-	The Hail test was completed on 14/12/2022. There was no evidence of mechanical damage during the test and the samples met the following requirements, 1. Visual Inspection test No Visual defects found 2. Maximum power determination Power degradation≤5% 3. Insulation test -The measured insulatior resistance was not less than 15.50 MΩ. For more details, please refer test report.
3	10.16	Mechanical load test	-	_	-	-	The mechanical load test was completed on 12/09/2022. Ther was no damage after the test, and the samples met the following requirements, 1. Visual Inspection test No Visual defects found 2. Maximum power determination power degradation≤5% 3 Insulation test -The measured insulation resistance was not less than 15.50 MΩ For more details please refer test report.
4	10.15	Wet leakage current test	-	-	-	-	All the modules passed the initial ar final wet leakage current test. For more details, pleas refer to the test report.

5	10.14	Robustness of termination test	-	- <u>-</u>	- Test date: 14/12/2022. There was no evidence of a major defect after the Robustness of termination Test and the samples met the following requirements, 1. Visual Inspection test. No Visual defects found 2. Maximum power determination, Power degradation≤5% 3. Insulation test- The measured insulation resistance was not less than 15.50 MΩ.For more details, please refer test report
6	10.13	Damp heat test	-		- There was no evidence of a major defect in the Damp Heat Test and the samples met the following requirements, 1. Visual Inspection test. No Visual defects found 2. Maximum power determination, Power degradation $\leq 5\%$ 3. Insulation test- The measured insulation resistance was not less than 15.50 MΩ 4. Wet Leakage current test- The measured insulation resistance was not less than 15.50 MΩ. For more details, please refer test report.
7	10.12	Humidity freeze test	-		- There was no evidence of a major visual defect in the Humidity Freeze Test and the samples met the following requirements, 1. Visual Inspection test. No Visual defects found 2. Maximum power determination, Power degradation $\leq 5\%$ 3. Insulation test- The measured insulation resistance was not less than 15.50 M $\Omega$ . For more details, please refer test

8	10.11	Thermal cycling test	-	 <ul> <li>There was no evidence of a major defect in the Thermal Cycling test and the samples met the following requirements, 1.</li> <li>Visual Inspection test. No Visual defects found 2.</li> <li>Maximum power determination, Power degradation≤5% 3.</li> <li>Insulation test- The measured insulation resistance was not less than 15.50</li> <li>MΩ.For more details, please refer test report</li> </ul>
9	10.10	UV preconditioning	-	 - There was no evidence of a major defect in UV exposure and the samples met the following requirements, 1. Visual Inspection test. No Visual defects found 2. Maximum power determination, Power degradation $\leq 5\%$ 3. Insulation test- The measured insulation resistance was not less than 15.50 M $\Omega$ .For more details, please refer test report
10	10.9	Hot-spot endurance test	-	- There was no evidence of a major visual defect in the Hotspot test and the samples met the following requirements, 1. Visual Inspection test. No Visual defects found 2. Maximum power determination, Power degradation $\leq 5\%$ 3. Insulation test- The measured insulation resistance was not less than 15.50 M $\Omega$ 4. Wet Leakage current test- The measured insulation resistance was not less than 15.50 M $\Omega$ . For more details, please refer test report

11	10.8	Outdoor exposure test	-	-	-	-	From 30/11/2022 to 06/12/2022. The module is exposed to required irradiation dosage. The samples met the following requirements, 1. Visual Inspection test - No Visual defects found 2. Maximum power determination - Power degradation $\leq 5 \%$ 3. Insulation test - The measured insulation resistance was not less than 15.50 MΩ. For more details, please refer test report.
12	10.7	Performance at low irradiance	-	-	-	-	The measured power at low irradiance value is 102.90W. (Module No.: MCIND/ 2022/0394). For more details, please refer test report.
13	10.6	Performance at STC and NOCT	-	-	-	-	The measured power at STC value is 539.91 W and NOCT value is 400.01W. (Module No.: MCIND/ 2022/0394). For more details, please refer test report.
14	10.5	Measurement of NOCT	-	-	-	-	The measured NOCT value is 47.00. (Module No. MCIND/ 2022/0394). For more details, please refer test report.
15	10.4	Measurement of temperature coefficients	-	-	-	-	Short circuit current $\alpha$ [%/°C]: 0.022 Open circuit voltage $\beta$ [%/°C]: -0.172 Peak power $\delta$ [%/ °C] : -0.316 (Module no.: MCIND/ 2022/0394) For more details, please refer to the test report.
16	10.3	Insulation test	-	-	-	-	All modules passed the test. For more details. Please refer test report.
17	10.2	Maximum power determination	-	-	-	-	All Modules passed the test. Initial test date: 10/10/2022. Final test date: 16/12/2022. Please refer test report for more details.
18	10.1	Visual inspection	-	-	-	-	All the modules passed the visual inspection test. Test date: 10/10/2022. For more details, please refer to the test report.
19	4	Marking	-	-	-	-	All Markings are as per the standard criteria. For more information, please refer to the test report

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## Section Report No. : 22ED759N\_1\_A1

PART D. REMARKS

Please refer attached test report MCIND/22-23/LB/089.V1

Hebin Manuel OIC Electrical (Authorized Signatory) Authorized on: 19 Dec, 2022 17:55 PM

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# Test Report issued under the responsibility of:



### SUMMARY OF REPORT No. MCIND/22-23/LB/089.V1, DATED (DD/MM/YYYY):

### 19/12/2022

### ULR No. TC89062200000089F

### (Number of pages in test report: Page no.1 to 88) TEST FORMAT AS PER IS 14286:2010 (First Revision)

1. Name of n	nanufacturer:	UNIQUE SUN POWER LLP
2. Product:		Crystalline Silicon Terrestrial Photovoltaic
2. 11000000		Modules (Si wafer based)
3. Test Requ	est Number:	SC22SPI01032
4. Model:		144 CELL FAMILY: Mono (Half-Cut Cell)
		SUN144P550 (Representative Model)
		SUN144P545, SUN144P540, SUN144P535,
		SUN144P530, SUN144P525, SUN144P520
		132 CELL FAMILY: Mono (Half-Cut Cell)
		SUN132P505, SUN132P500, SUN132P495,
		SUN132P490, SUN132P485, SUN132P480,
		SUN132P475, SUN132P470
		120 CELL FAMILY: Mono (Half-Cut Cell)
		SUN120P465, SUN120P460, SUN120P455,
		SUN120P450, SUN120P445, SUN120P440,
		SUN120P435
		108 CELL FAMILY: Mono (Half-Cut Cell)
		SUN108P420, SUN108P415, SUN108P410,
		SUN108P405, SUN108P400
	ferences provided	Yes
	able): Yes/No	
	ferences verified as per MNRE s for series formulation:	Yes
Yes/No		





**Solar PV Laboratory** 

ULR No : TC890622000000089F		Report No.: MCIND/22-23/LB/BIS/089.V1		
7. Te	est Results:			
SL.NO.	TEST REQUIREMENTS	CLAUSE	VERDICT	
1	Marking	4	Р	
2	Visual Inspection	10.1	Р	
3	Maximum Power Determination	10.2	Р	
4	Insulation Test	10.3	Р	
5	Measurement of Temperature Coefficient	10.4	Р	
6	Measurement of NOCT	10.5	Р	
7	Performance at STC & NOCT	10.6	Р	
8	Performance at low Irradiance	10.7	Р	
9	Outdoor Exposure Test	10.8	Р	
10	Hotspot Endurance Test	10.9	Р	
11	UV preconditioning	10.10	Р	
12	Thermal Cycling Test	10.11	Р	
13	Humidity Freeze Test	10.12	Р	
14	Damp Heat Test	10.13	Р	
15	Robustness and Termination Test	10.14	Р	
16	Wet Leakage Test	10.15	Р	
17	Mechanical Load Test	10.16	Р	
18	Hail Test	10.17	Р	
19	Bypass Diode Thermal Test	10.18	Р	

#### **General Information:**

1. The conformity certificates of critical components are verified to ensure complete testing of product under test and details regarding harmonized IEC/UL Standards (where IS standards are not available) are also provided in the list of critical component.

#### CONCLUSION:

- 1. Sample meets all relevent requirements of IS 14286:2010 (First Revision):
- 2. Sample fails to meet the following test requirements:

I, hereby, undertake that the verdict stated in the test reports for all the tests matches with the test results. The sample meets all relevant requirements of IS 14286:2010: /does not meet the requirementsstated above at 2) of conclusion. If any deviation is found, suitable punitive action may be taken by BIS.

G. Ganesh

#### Date (DD/MM/YYYY): 19/12/2022

### (Signature of authorized person)

This report is issued for test request number" **SC22SPI00762**". The lab couldn't upload the report due to a technical issue. Hence, the customer raised a new test request number" "**SC22SPI01032**" to upload the reports.

This test report is uploaded under the test request number" **SC22SPI01032**" with the results of **"SC22SPI00762"**.

TC-8906



**Solar PV Laboratory** 

ULR No : TC890622000000089F

Report No.: MCIND/22-23/LB/BIS/089.V1

TEST REPORT
IS 14286: 2010 First Revision
Crystalline Silicon Terrestrial Photovoltaic (PV) Modules
- Design Qualification and Type Approval

Report Number:	MCIND/22-23/LB/089.V1
ULR Number	TC89062200000089F
Discipline	Electronics Testing
Group	Miscellaneous Products (Solar PV Modules)
Test Request no	SC22SPI01032
Date of issue	19/12/2022
Total number of pages	88

Test Report QR Code.....:



Name of testing Laboratory	
Preparing the Report 1	Mitsui Chemicals India Private Limited
Applicant's name	UNIQUE SUN POWER LLP
Address:	BL No. 2281/2/1/1, Sub Plot. 1-A, Tadkeshwar, Near
	Areth Minnor Canal, Mandvi, Surat, Gujarat – 394170
Test Specification:	
Standard	IS 14286: 2010
Test procedure:	BIS
Non-standard test method:	N/A
Master TRF:	Dated 19.02.2018
General disclaimer:	
The test results presented in this report	relate only to the object tested





**Solar PV Laboratory** 

ULR No : TC890622000000089F	Report No.: MCIND/22-23/LB/BIS/089.V
Test item description:	Crystalline Silicon Photovoltaic Modules (Si wafer based)
Trade mark:	SUNGRA
Manufacturer:	UNIQUE SUN POWER LLP
Address:	BL No. 2281/2/1/1, Sub Plot. 1-A, Tadkeshwar, Near Areth Minnor Canal, Mandvi, Surat, Gujarat - 394170
Model/Type reference:	144 CELL FAMILY: Mono (Half-Cut Cell)
	SUN144P550 (Representative Model)
	SUN144P545, SUN144P540, SUN144P535,
	SUN144P530, SUN144P525, SUN144P520
	132 CELL FAMILY: Mono (Half-Cut Cell)
	SUN132P505, SUN132P500, SUN132P495,
	SUN132P490, SUN132P485, SUN132P480,
	SUN132P475, SUN132P470
	120 CELL FAMILY: Mono (Half-Cut Cell)
	SUN120P465, SUN120P460, SUN120P455,
	SUN120P450, SUN120P445, SUN120P440,
	SUN120P435
	108 CELL FAMILY: Mono (Half-Cut Cell)
	SUN108P420, SUN108P415, SUN108P410,
	SUN108P405, SUN108P400

Ratings:	Maximum System Voltage: 1500 VDC		
	Maximum over current protection rating: 25 A		
	144 CELL FAMILY: Mono (Half-Cut Cell)		
	SUN144P550 (Representative Model)		
	SUN144P545, SUN144P540, SUN144P535,		
	SUN144P530, SUN144P525, SUN144P520		
	132 CELL FAMILY: Mono (Half-Cut Cell)		
	SUN132P505, SUN132P500, SUN132P495,		



Mitsui Chemicals Group

**Solar PV Laboratory** 

ULR No : TC890622000000089F	Report No.: MCIND/22-23/LB/BIS/089.V1	
	SUN132P490, SUN132P485, SUN132P480,	
	SUN132P475, SUN132P470	
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	SUN120P450, SUN120P445, SUN120P440,	
	SUN120P435	
	108 CELL FAMILY: Mono (Half-Cut Cell)	
	SUN108P420, SUN108P415, SUN108P410,	
	SUN108P405, SUN108P400	

Responsible Testing Laboratory (as applicable), testing procedure and testing location(s):				
	Testing laboratory	Mitsui Chemicals India Private Limited		
Testing location/address:		Plot no. 5 & 6, Swastik Industrial Estate, Sarkhej-Bavla Highway, Village: Sari, Tal: Sanand, Ahmedabad- 382220, INDIA		
Tested by (name + signature) :		Mr. Saran Bhaskar	A	
Revi	ewed by (name + signature):	Mr. Hebin Manuel	Heburton	
Аррі	roved & Issued by (name + signature) :	Mr. Gowri Ganesh	G. Ganesh	